

**ENGR-2350**

**Embedded Control**

**Data Acquisition: ADC**

# Data Acquisition

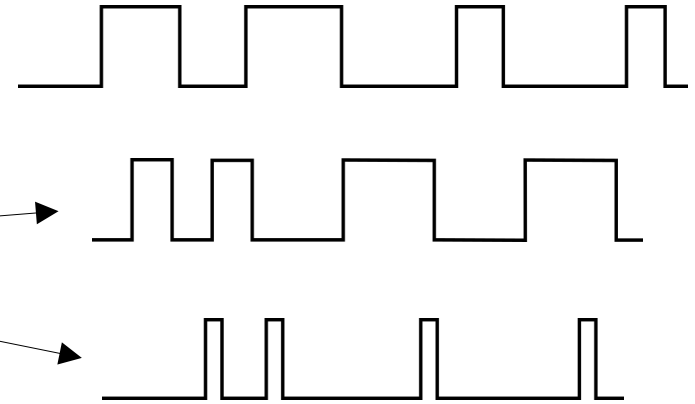
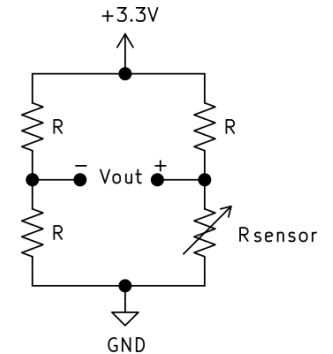
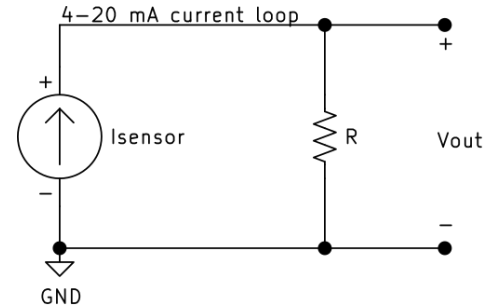
Need more than just plain Digital Inputs to perform most control applications (input → output):

- Temperature INPUT to control Heater
- Distance INPUT to control Drive power
- Speed INPUT to control Cruise control
- Light level INPUT to control screen brightness
- Pressure INPUT to control relief valves
- Tilt INPUT to control game character movement
- Etc.

# Data Acquisition

Additional Types of Input Data:

- **Analog Voltages and Currents:**
  - Sensors may output analog voltage directly.
  - Converted 4-20 mA current loops
  - Variable resistance + Bridges
- **Time/Frequency Based Signals:**
  - Pulse width modulated (PWM)
  - Frequency modulated (FM)
  - Delay based signals
- More...



# Data Acquisition: Methods

## Analog Voltages:

- Analog-to-Digital Converters (ADC):
  - Maps an **Analog** voltage to a **Digital** number
  - Conversion range limited to **Reference Voltages**
  - Loss of information due to **Quantization**
  - Limited **Sampling** speed

## Time/Frequency Based Signals:

- Timer **Capture: Last Lecture**

# Analog-to-Digital Converter (ADC)

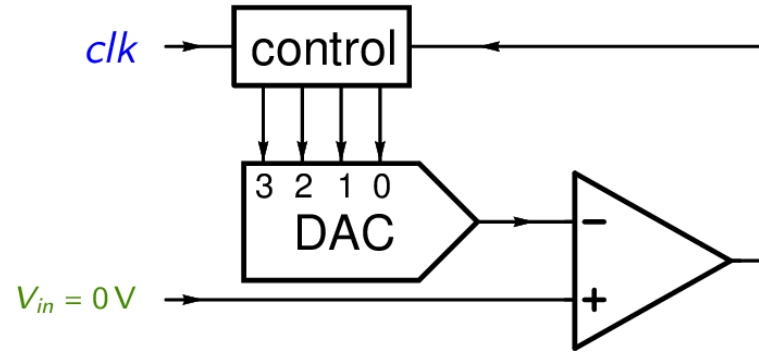
# Analog-to-Digital Converters (ADC)

- Convert an analog voltage to a digital value.
  - E.g., 1.3 V  $\rightarrow$  4362 [ADC unit: LSb]
- How? Many different ways...
  - Most common:
    - Successive Approximation Register ADC**
    - Work from MSb to LSb, testing if “guess” is too high/too low

## Successive Approximation – example of a 4-bit ADC

# SAR ADC

[https://en.wikipedia.org/wiki/Successive-approximation\\_ADC](https://en.wikipedia.org/wiki/Successive-approximation_ADC)



Resolution:	
$5V \times 1/2$	2.5000 V
$5V \times 1/4$	1.2500 V
$5V \times 1/8$	0.6250 V
$5V \times 1/16$	0.3125 V
...	
$5V \times 1/1024$	0.0049 V

# ADC: Mapping (typical)

- Conversion Mapping (uint16\_t output):
  - Single-Ended Mode

$$N_{\text{ADC}} = 2^{N_{\text{bits}}} \frac{V_{\text{in}+} - V_{\text{Ref-}}}{V_{\text{Ref+}} - V_{\text{Ref-}}} \quad V_{\text{Ref-}} \leq V_{\text{in}+} < V_{\text{Ref+}}$$

- Estimated Voltage:  $\hat{V}_{\text{in}+} = \frac{N_{\text{ADC}}}{2^{N_{\text{bits}}}} (V_{\text{Ref+}} - V_{\text{Ref-}}) - V_{\text{Ref-}}$

# ADC: Mapping (typical)

- Conversion Mapping (uint16\_t output) if  $V_{\text{Ref-}} = 0$ 
  - Single-Ended Mode

$$N_{\text{ADC}} = 2^{N_{\text{bits}}} \frac{V_{\text{in+}}}{V_{\text{Ref+}}} \quad 0 \leq V_{\text{in+}} < V_{\text{Ref+}}$$

- Estimated Voltage:

$$\hat{V}_{\text{in+}} = \frac{N_{\text{ADC}}}{2^{N_{\text{bits}}}} V_{\text{Ref+}}$$

# ADC: Example Conversions

- Single-Ended Conversion Mapping Example:

$$V_{\text{in}+} = 1.3\text{V} \quad V_{\text{R}+} = 3.3\text{V} \quad V_{\text{R}-} = 0\text{V} \quad N_{\text{bits}} = 14$$

$$N_{\text{ADC}} = 2^{14} \frac{1.3 - 0}{3.3 - 0} = 6454.3 \rightarrow 6454$$

*Output is always an integer!*

- Quantization Error:

$$6454 = 2^{14} \frac{\hat{V}_{\text{in}+} - 0}{3.3 - 0} \rightarrow \hat{V}_{\text{in}+} = 1.299939\text{V} \quad \text{error} = 61 \mu\text{V}$$

# ADC: Example Conversions

- Single-Ended Conversion Mapping Example:

$$V_{\text{in}+} = 1.3\text{V} \quad V_{\text{R}+} = 3.3\text{V} \quad V_{\text{R}-} = 0\text{V} \quad N_{\text{bits}} = 8$$

$$N_{\text{ADC}} = 2^8 \frac{1.3 - 0}{3.3 - 0} = 100.848 \rightarrow 100$$

- Quantization Error:

$$100 = 2^8 \frac{\hat{V}_{\text{in}+} - 0}{3.3 - 0} \rightarrow \hat{V}_{\text{in}+} = 1.289\text{V} \quad \text{error} = 11 \text{ mV}$$

# ADC: Mapping (typical)

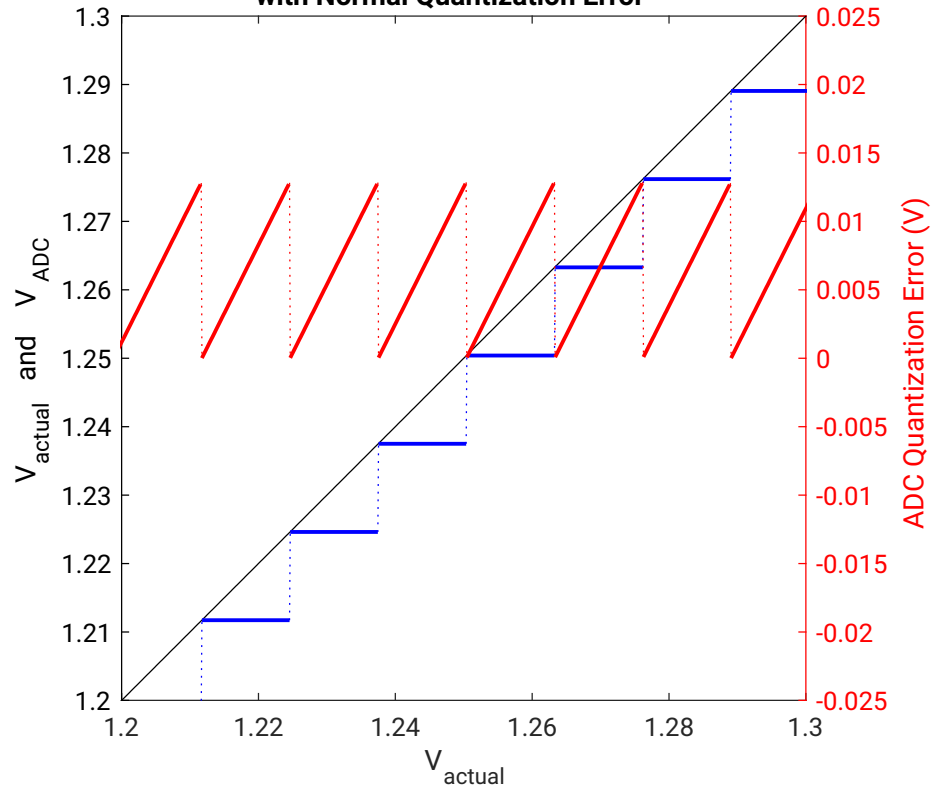
- Conversion Mapping (uint16\_t output):
  - Differential Mode (Voltage between two inputs)

$$N_{\text{ADC}} = 2^{N_{\text{bits}}-1} \frac{V_{\text{in}+} - V_{\text{in}-}}{V_{\text{Ref}+} - V_{\text{Ref}-}} + 2^{N_{\text{bits}}-1} \quad V_{\text{Ref}-} \leq V_{\text{in}-}, V_{\text{in}+} < V_{\text{Ref}+}$$

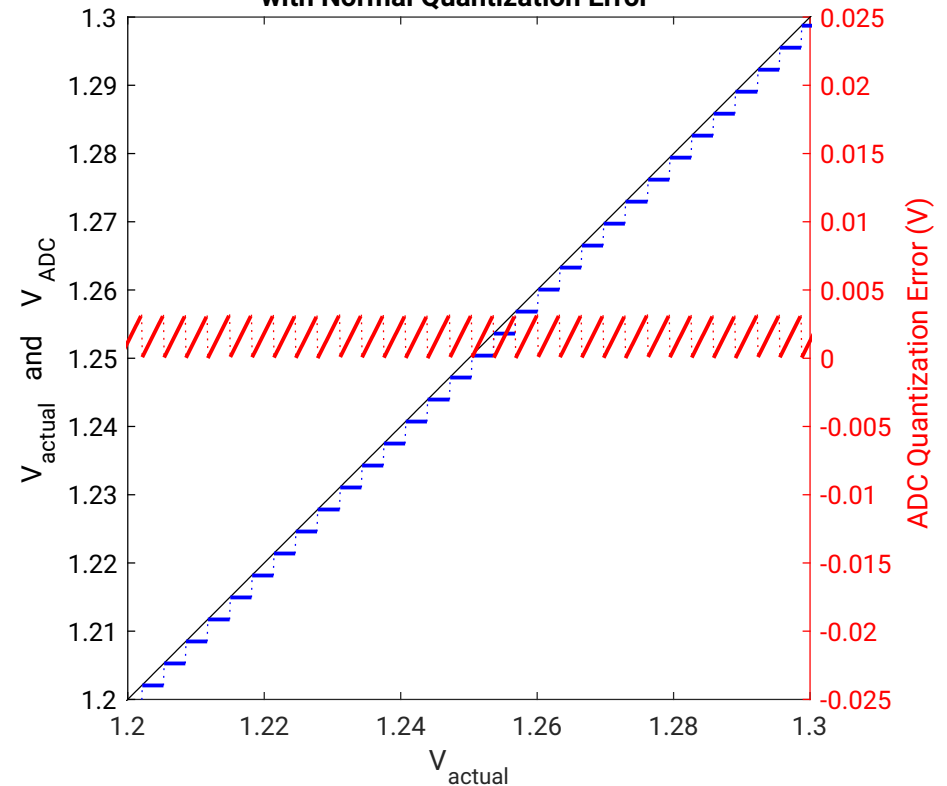
– Estimated Value:  $\hat{V}_{\text{in}+} - \hat{V}_{\text{in}-} = \left( \frac{N_{\text{ADC}}}{2^{N_{\text{bits}}-1}} - 1 \right) (V_{\text{Ref}+} - V_{\text{Ref}-}) + V_{\text{Ref}-}$

# ADC: Quantization Error (Vref 3.3V)

8-bit ADC Actual and Converted Voltages with Normal Quantization Error



10-bit ADC Actual and Converted Voltages with Normal Quantization Error



# ADC: Quantization Error

- Quantization Error is the error between the actual and the converted digital value:

$$Q_{\text{error}} = V_{\text{in}+} - \hat{V}_{\text{in}+}(N_{\text{ADC}})$$

- No quantization error when no rounding (e.g.):

$$N_{\text{ADC}} = \lfloor 123.00\dots \rfloor = 123 \rightarrow Q_{\text{error}} = 0, V_{\text{in}+} = \hat{V}_{\text{in}+}(N_{\text{ADC}})$$

- Maximum value occurs at maximum rounding (e.g.):

$$N_{\text{ADC}} = \lfloor 123.99\dots \rfloor = 123 \rightarrow Q_{\text{error}} = \text{max}, V_{\text{in}+} = \hat{V}_{\text{in}+}(N_{\text{ADC}} + 1)$$

$$\text{max}(Q_{\text{error}}) = \hat{V}_{\text{in}+}(N_{\text{ADC}} + 1) - \hat{V}_{\text{in}+}(N_{\text{ADC}}) = \hat{V}_{\text{in}+}(1)$$

# ADC: Quantization Error

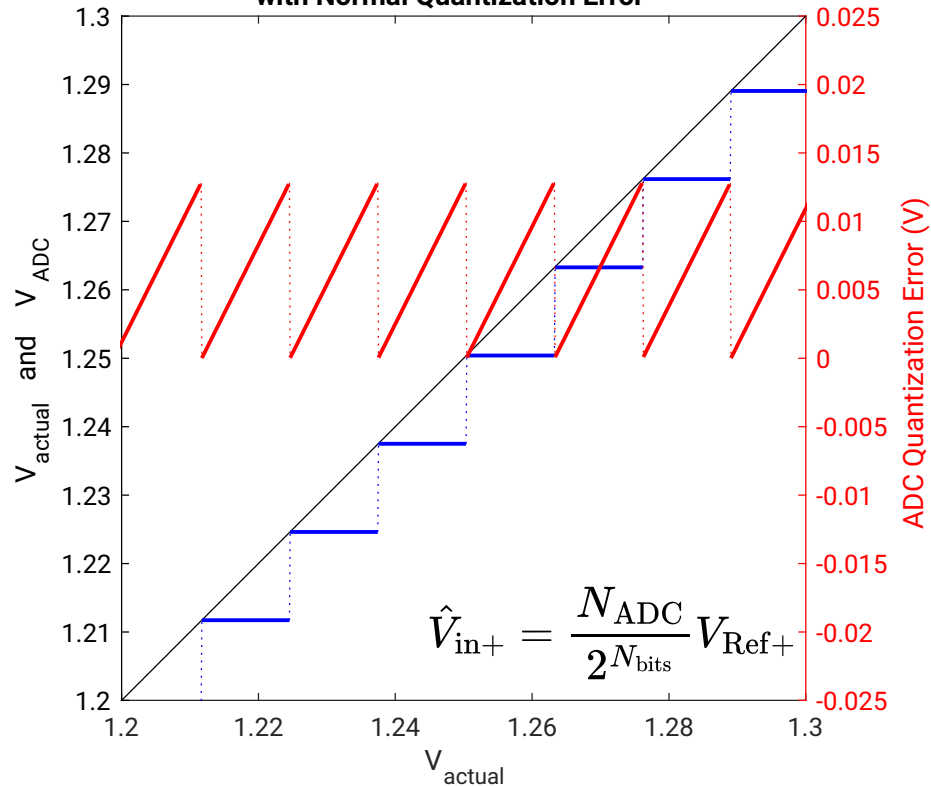
- Simple software change to reduce maximum quantization error:
  - Modify estimated voltage equation to add voltage offset of  $\frac{1}{2}$  the ADC resolution:

$$\hat{V}_{\text{in}+} = \frac{N_{\text{ADC}}}{2^{N_{\text{bits}}}} V_{\text{Ref}+} \longrightarrow \hat{V}_{\text{in}+} = \frac{N_{\text{ADC}} + 0.5}{2^{N_{\text{bits}}}} V_{\text{Ref}+}$$

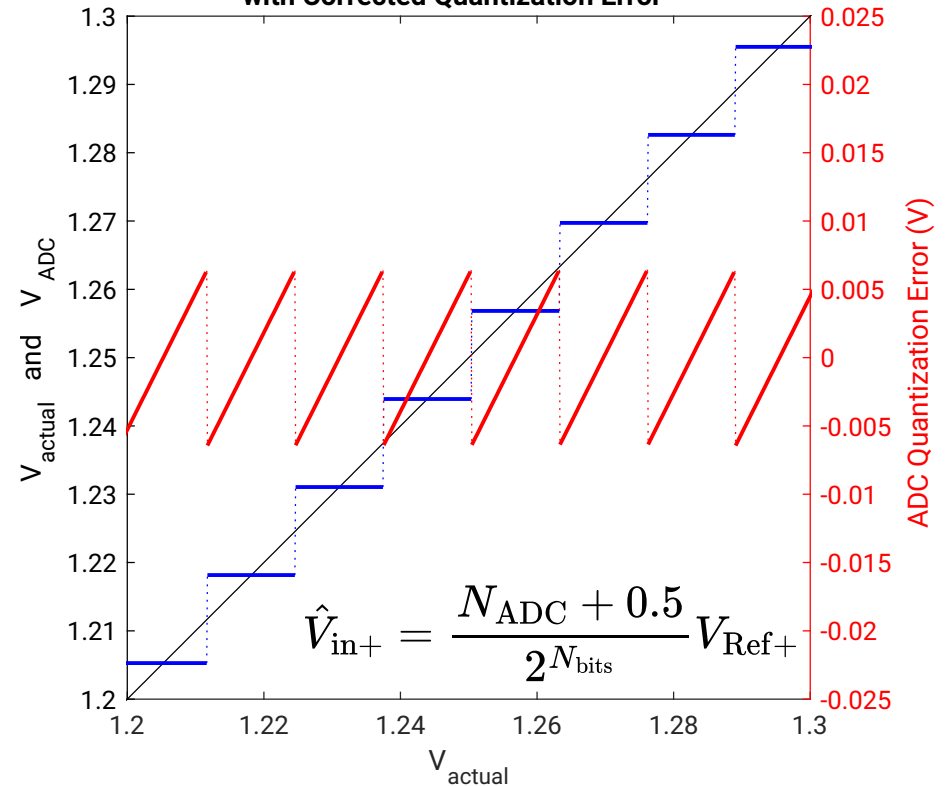
$$0 \leq Q_{\text{error}} < \hat{V}_{\text{in}+}(1) \longrightarrow -\frac{\hat{V}_{\text{in}+}(1)}{2} \leq Q_{\text{error}} < \frac{\hat{V}_{\text{in}+}(1)}{2}$$

# ADC: Quantization Error (Vref 3.3V)

8-bit ADC Actual and Converted Voltages with Normal Quantization Error

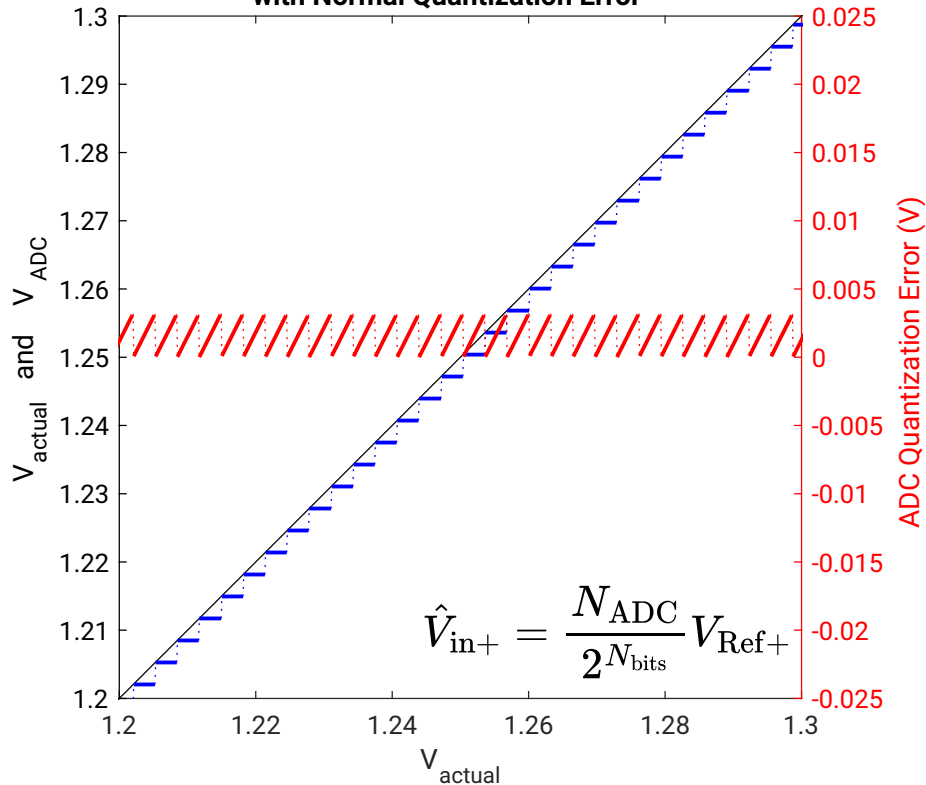


8-bit ADC Actual and Converted Voltages with Corrected Quantization Error

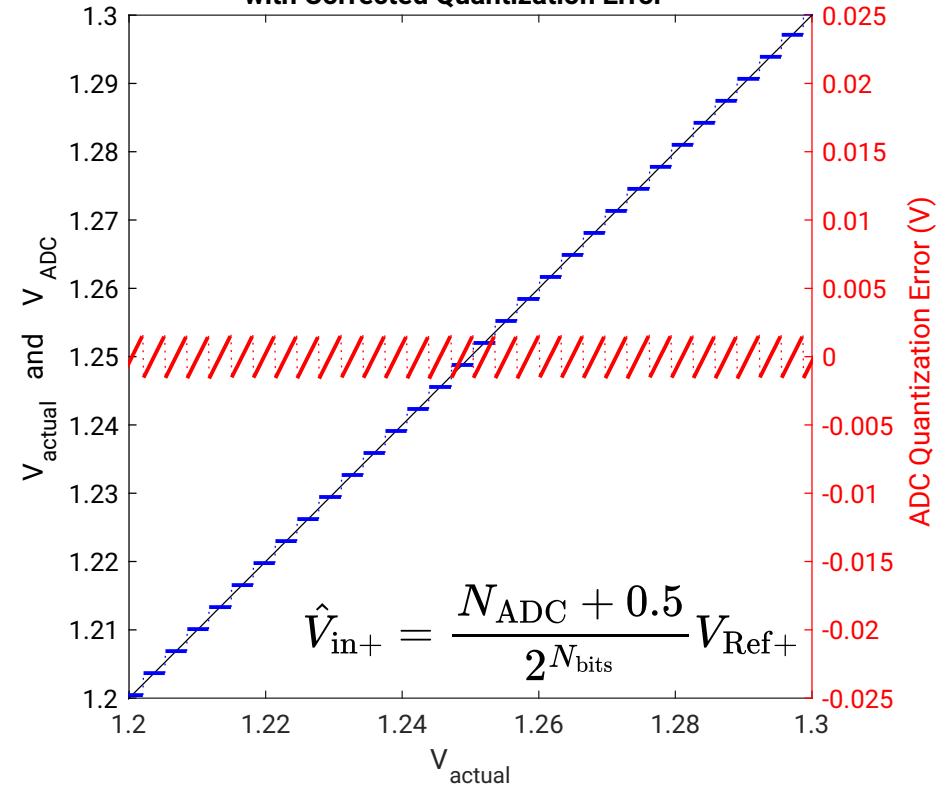


# ADC: Quantization Error (Vref 3.3V)

10-bit ADC Actual and Converted Voltages with Normal Quantization Error



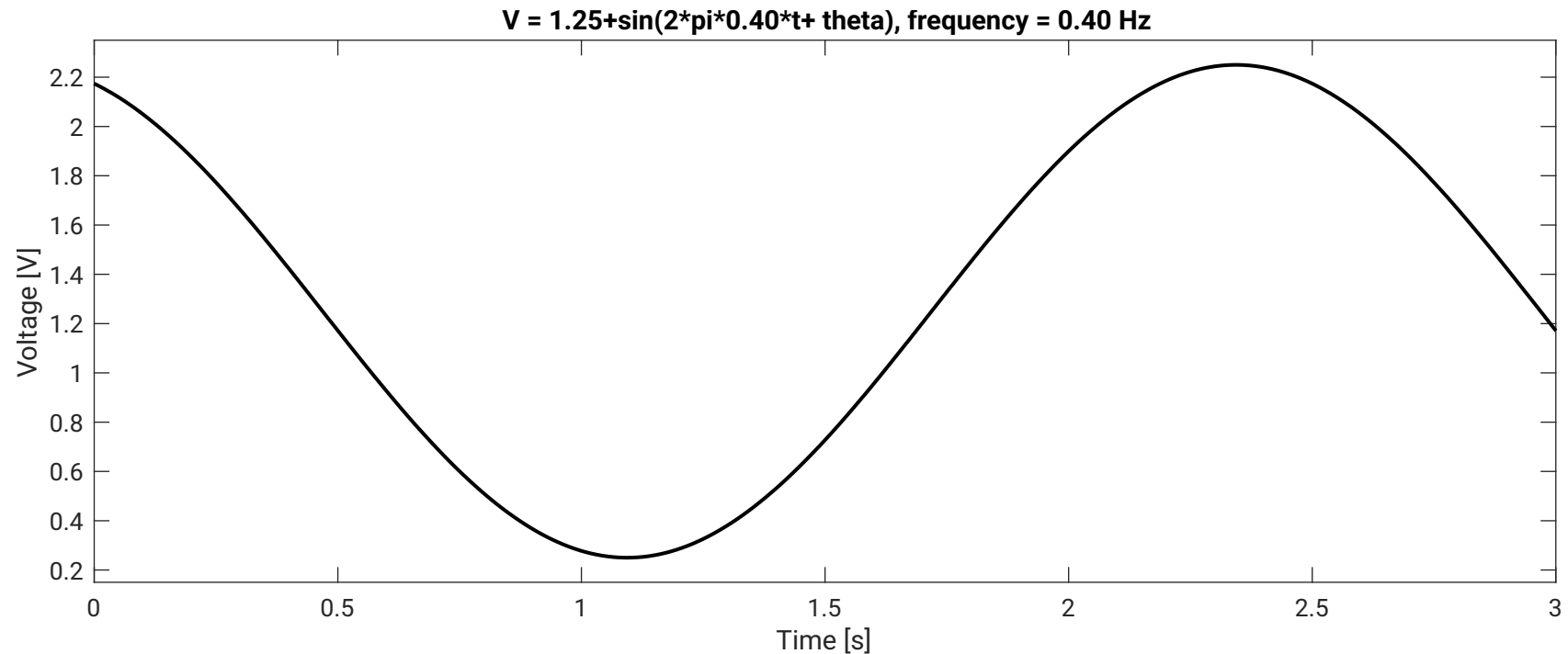
10-bit ADC Actual and Converted Voltages with Corrected Quantization Error



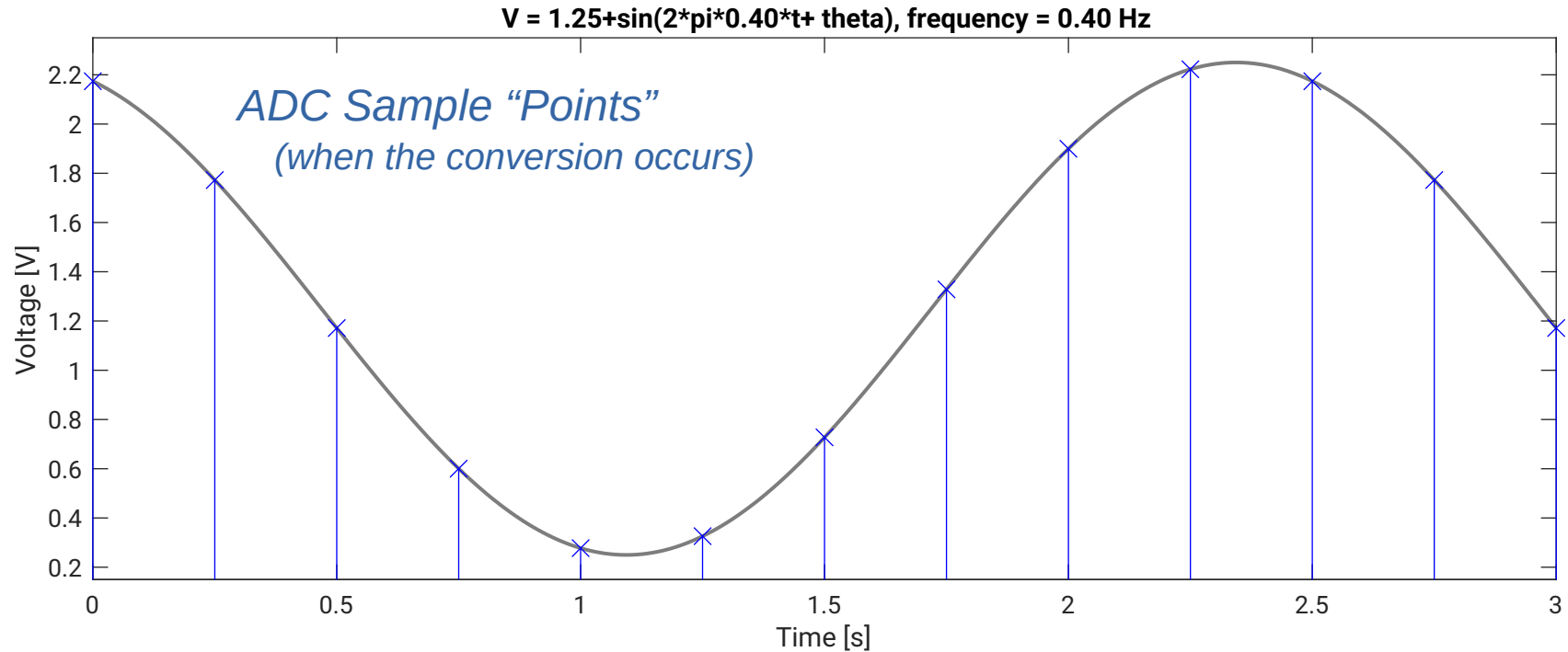
# ADC Sampling Rate Issues

- Measuring near-DC (constant) voltages is easy
- Signals that vary with time may not be represented well with an ADC...

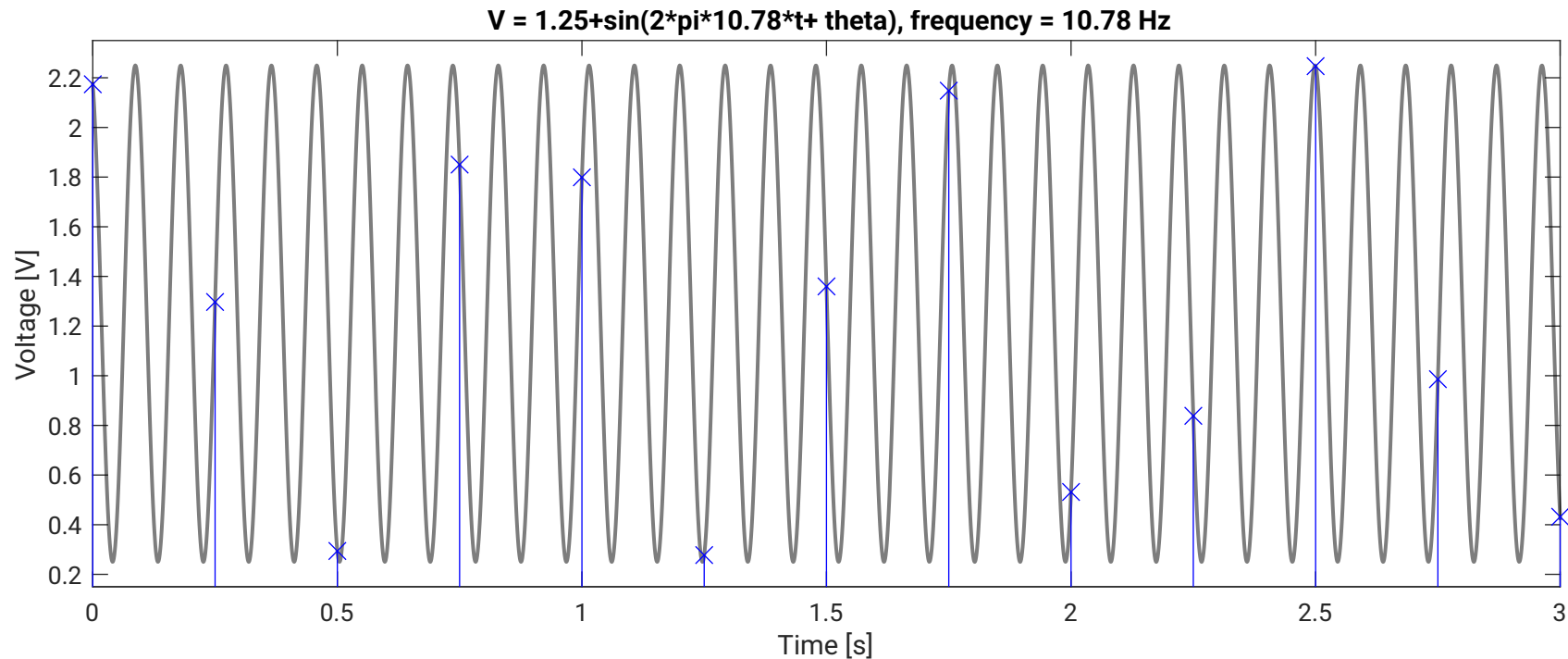
# ADC Sampling Rate Issues



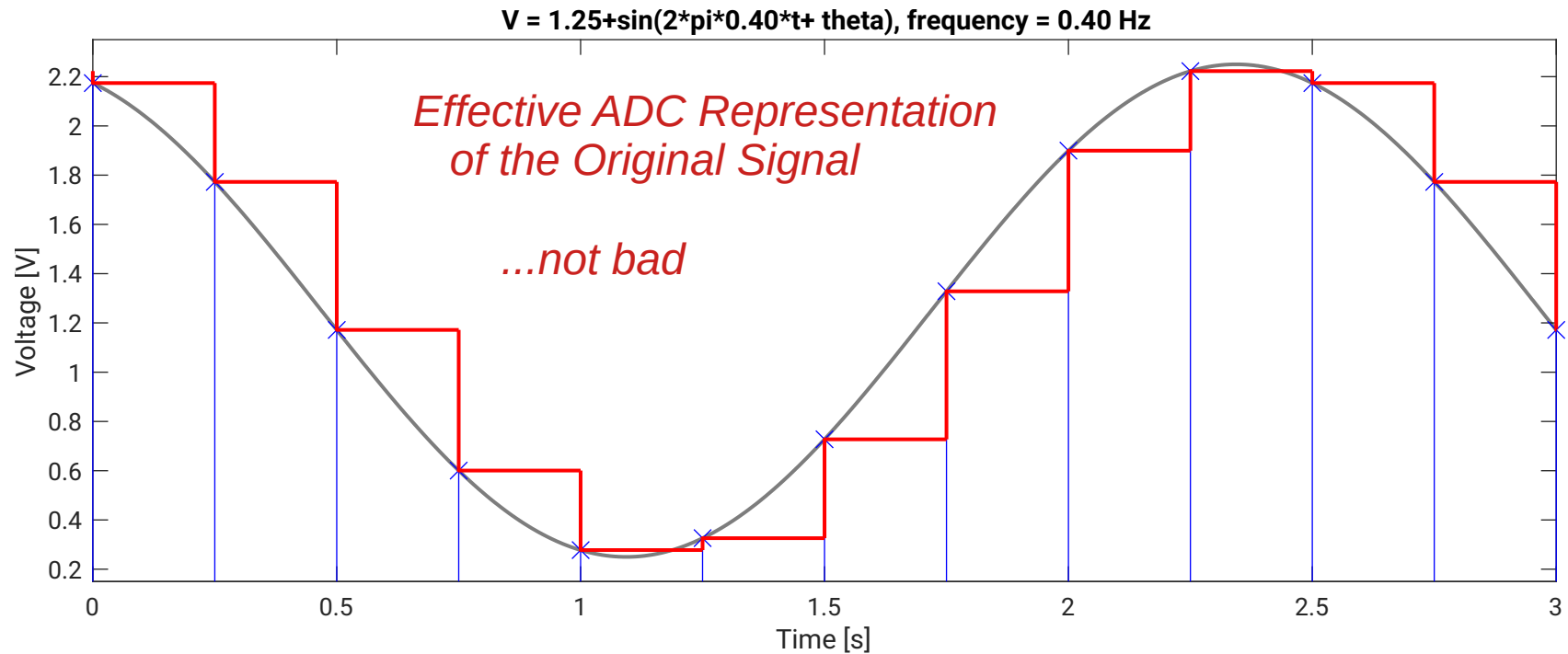
# ADC Sampling Rate Issues



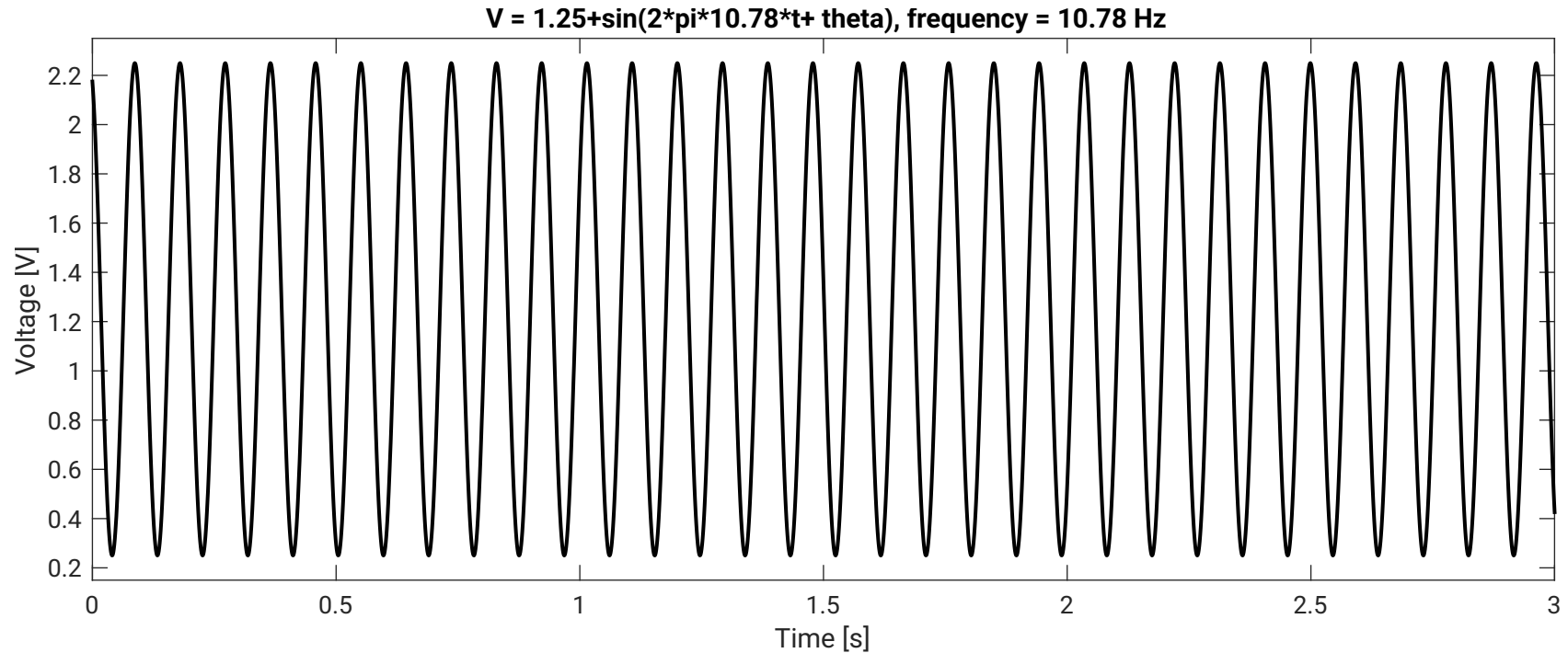
# ADC Sampling Rate Issues



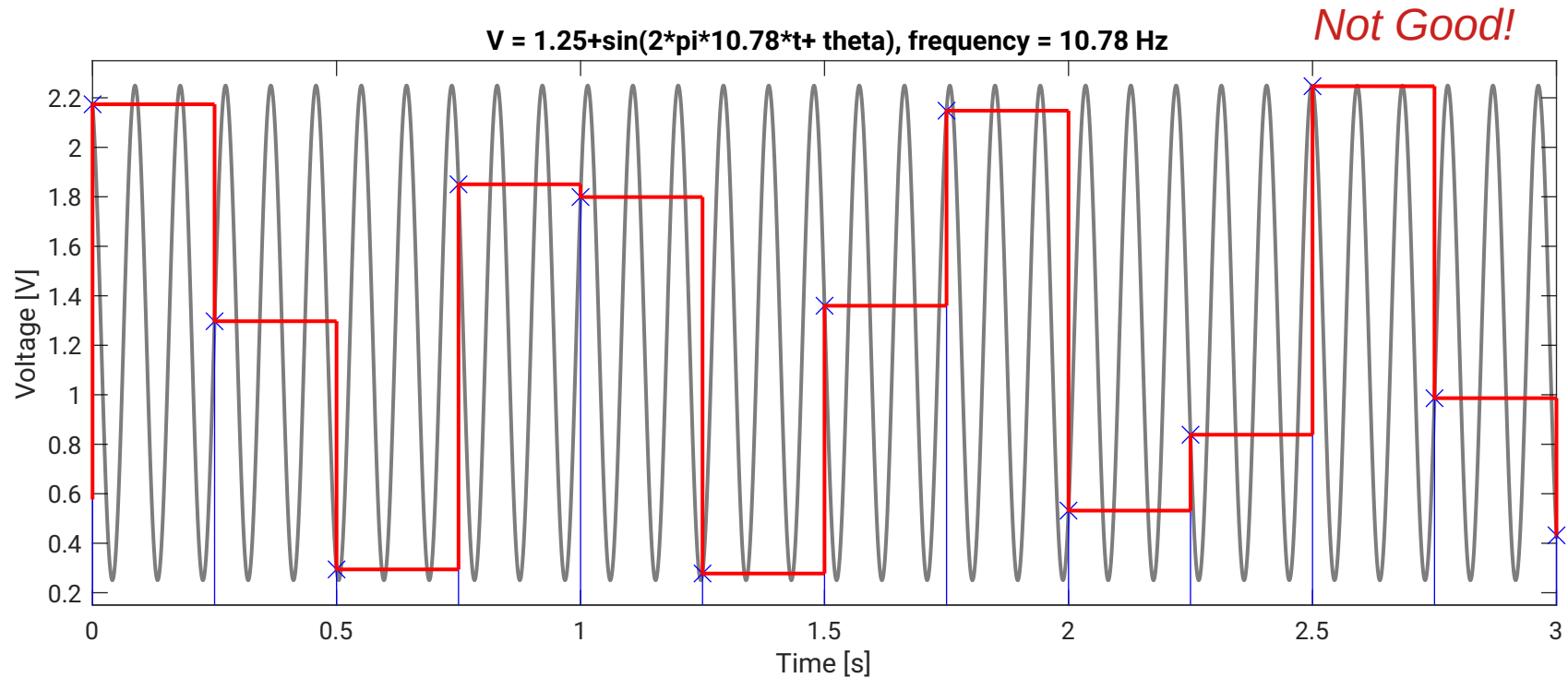
# ADC Sampling Rate Issues



# ADC Sampling Rate Issues



# ADC Sampling Rate Issues



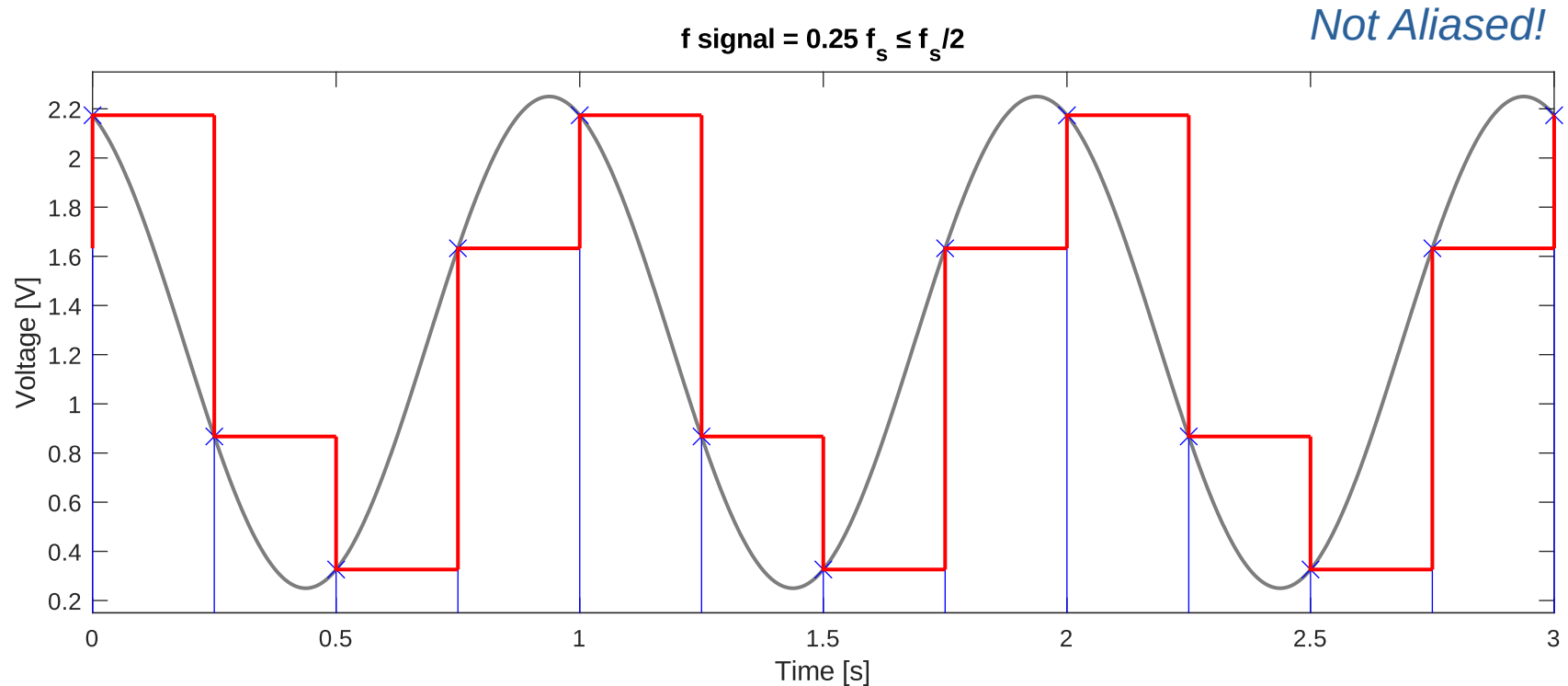
# ADC Sampling Rate Issues

- Measuring near-DC (constant) voltages is easy
- Signals that vary with time may not be represented well with an ADC.
  - “High speed” signals cannot be represented well!
    - High Speed: Relative to the ADC sampling rate
    - ADC sampling rate should be  $2 * \text{highest frequency}$ 
      - This is the “Nyquist Rate”

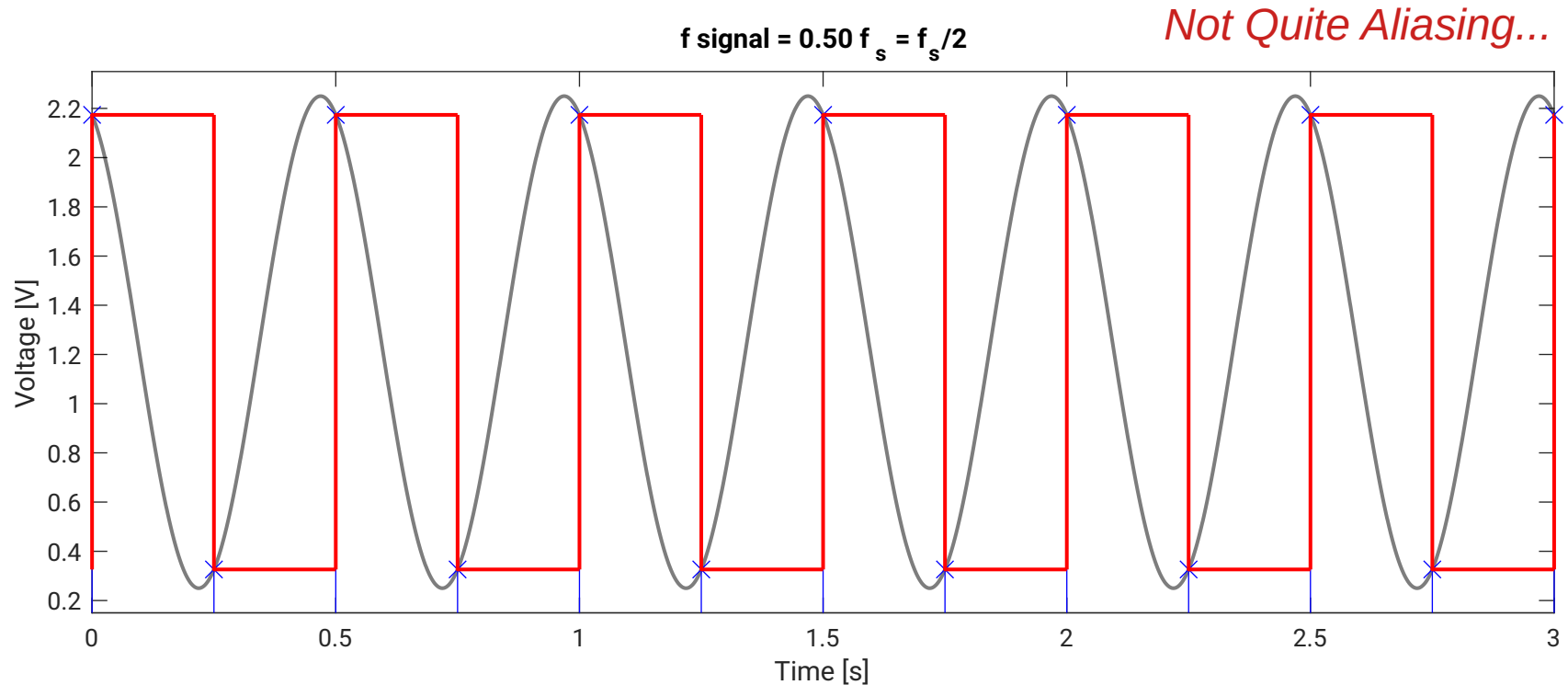
# ADC Sampling Rate Issues

- ADC sampling rate,  $f_s$ , should be  $2 * \text{highest frequency}$ 
  - This is the “Nyquist Rate”
- Any signals with frequencies  $\geq f_s / 2$  will “Alias”
  - “Alias” – any/all frequencies in a signal *after measurement* will look like a frequency  $\leq f_s / 2$
  - $f_s / 2$  is known as the “Nyquist Frequency”, or the maximum frequency able to be measured.

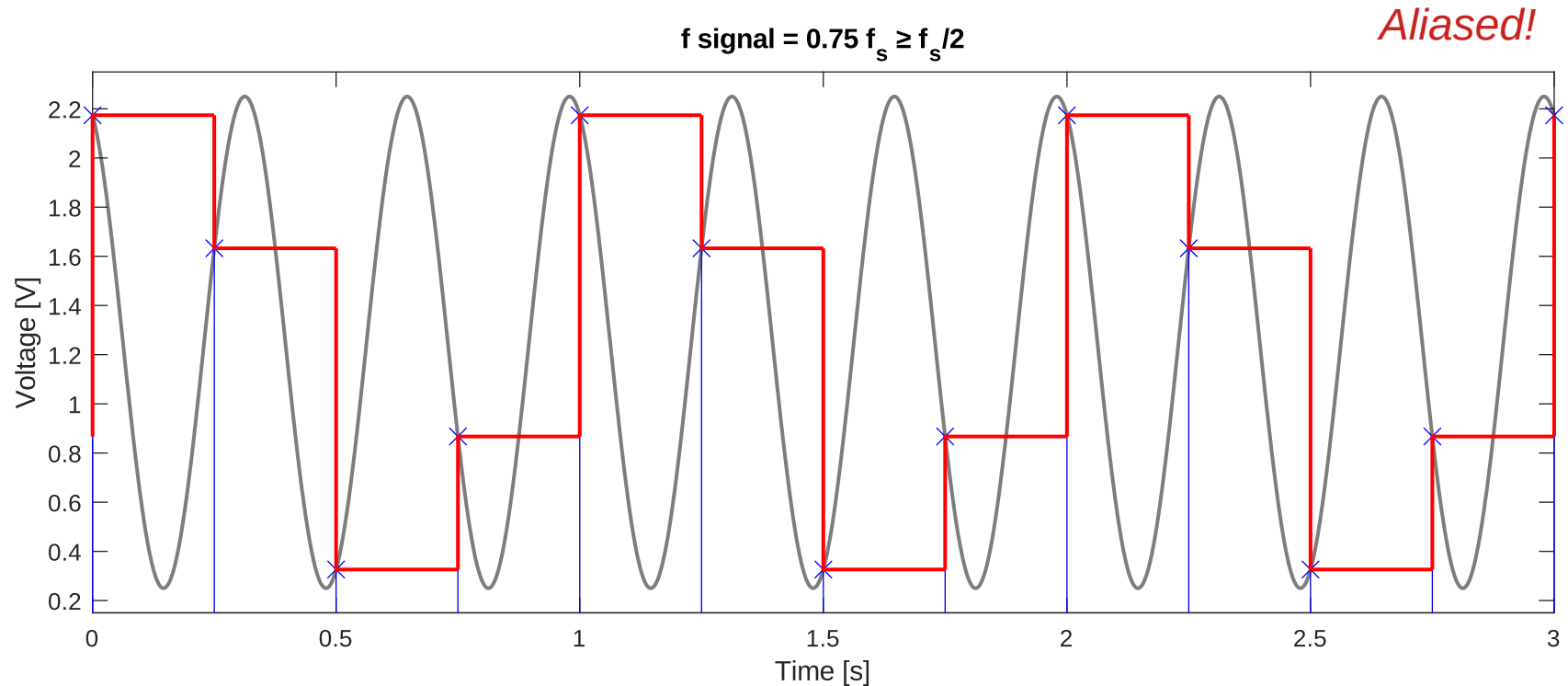
# ADC Aliasing Example



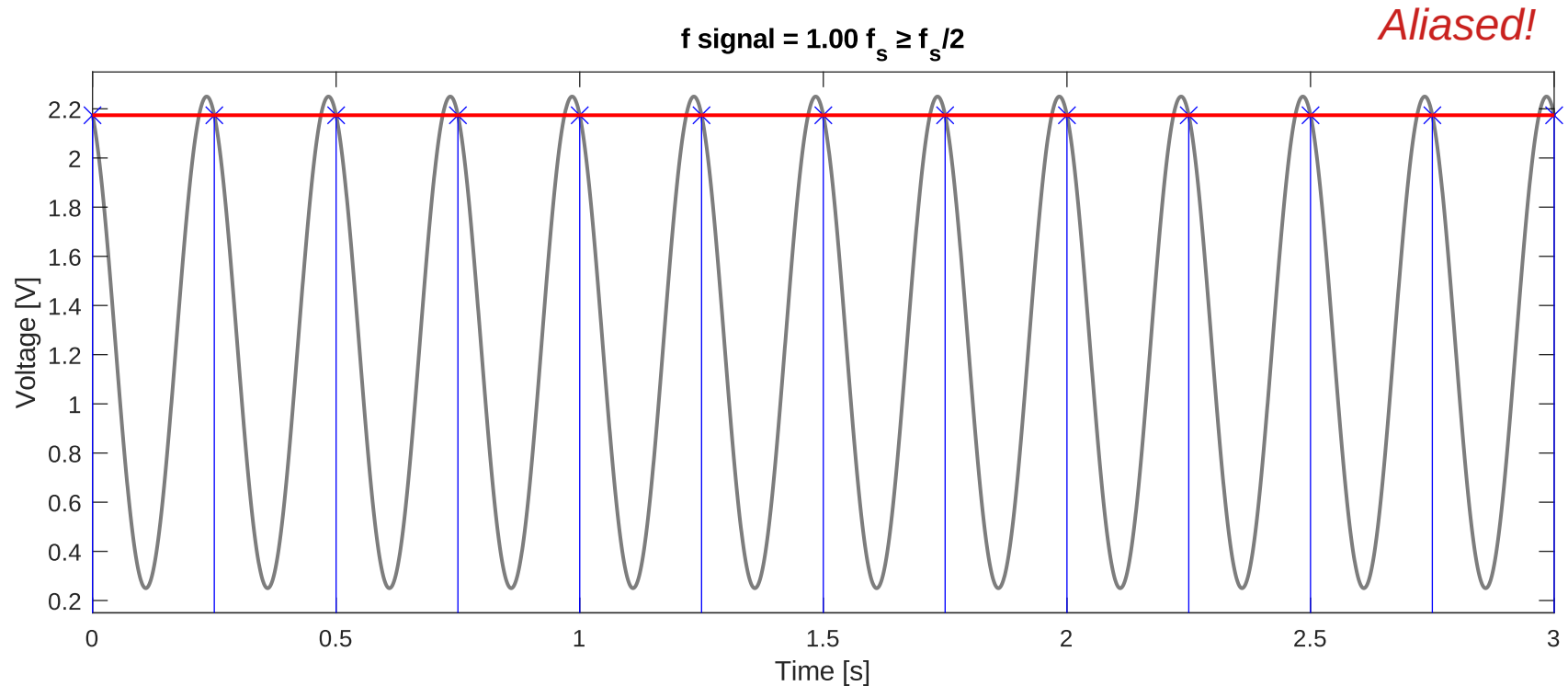
# ADC Aliasing Example



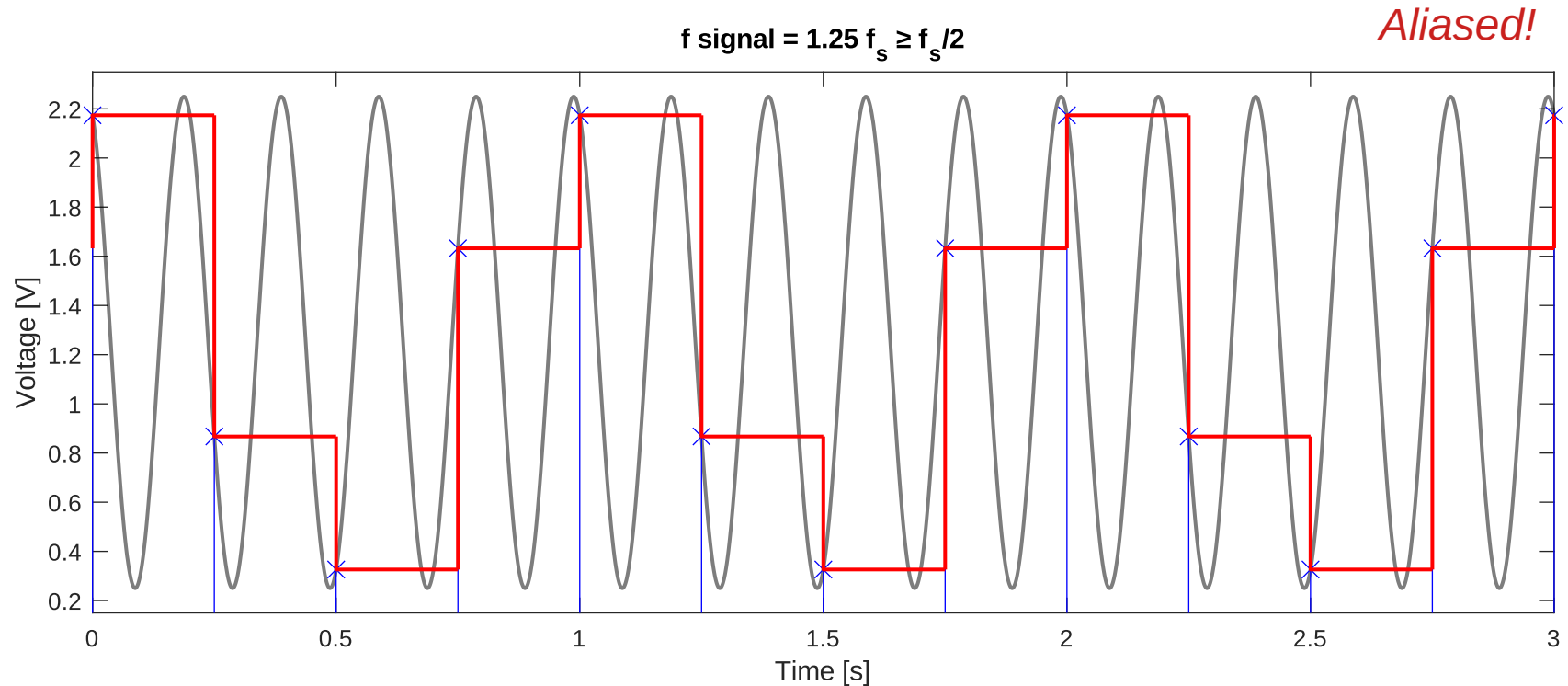
# ADC Aliasing Example



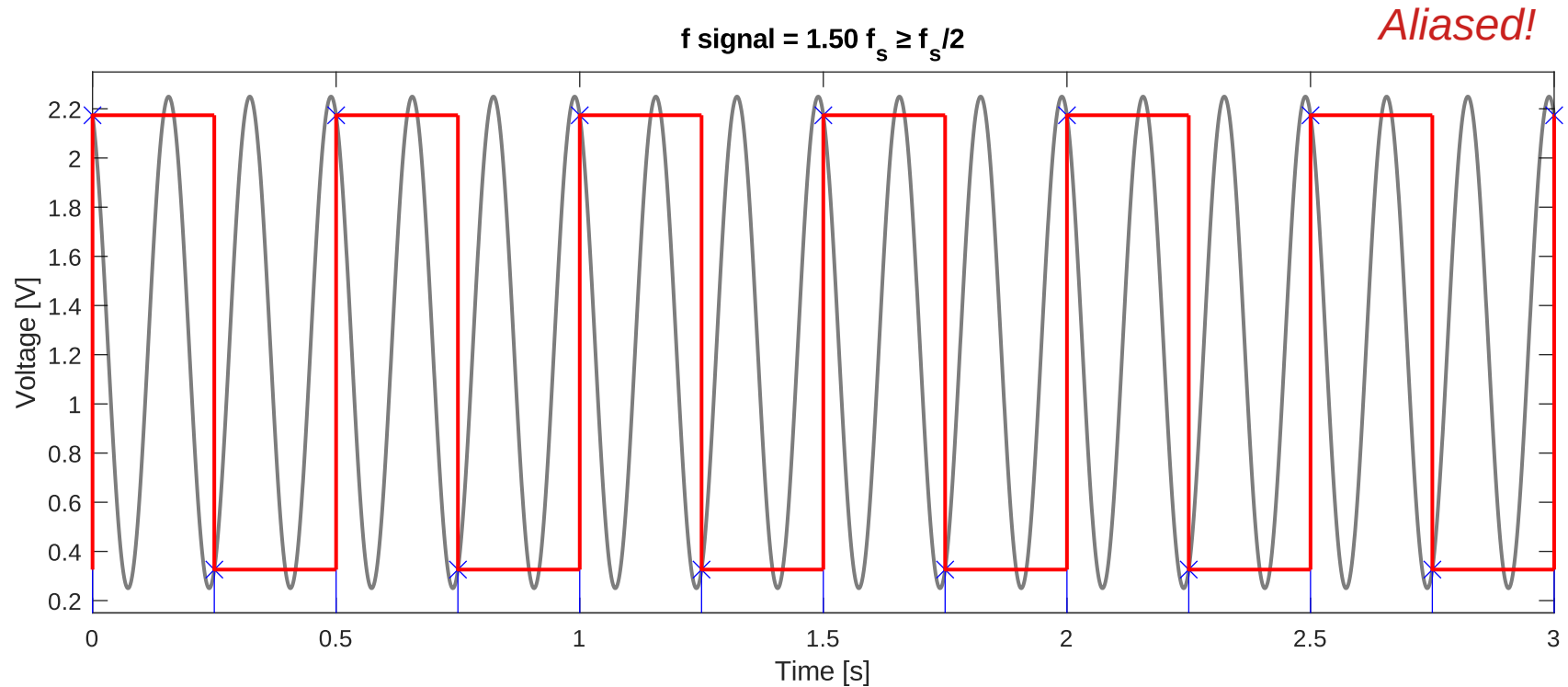
# ADC Aliasing Example



# ADC Aliasing Example



# ADC Aliasing Example



# MSPM0G3507 ADC: ADC12

- MSPM0G3507 has two SAR ADCs: **ADC0, ADC1**
  - 16\* input channels and configurable conversions
  - Selectable resolution: **8, 10, or 12** bits
  - **Single-Ended** only (no **Differential** inputs)
  - Voltage references selectable from **1.4 V, 2.5 V, 3.3 V** or provided externally through VREF+ pin\*\*

\* Not all 16 channels on each ADC are available on a pin

\*\* VREF+ pin is not accessible by default on the LaunchPad DevBoard

# ADC12

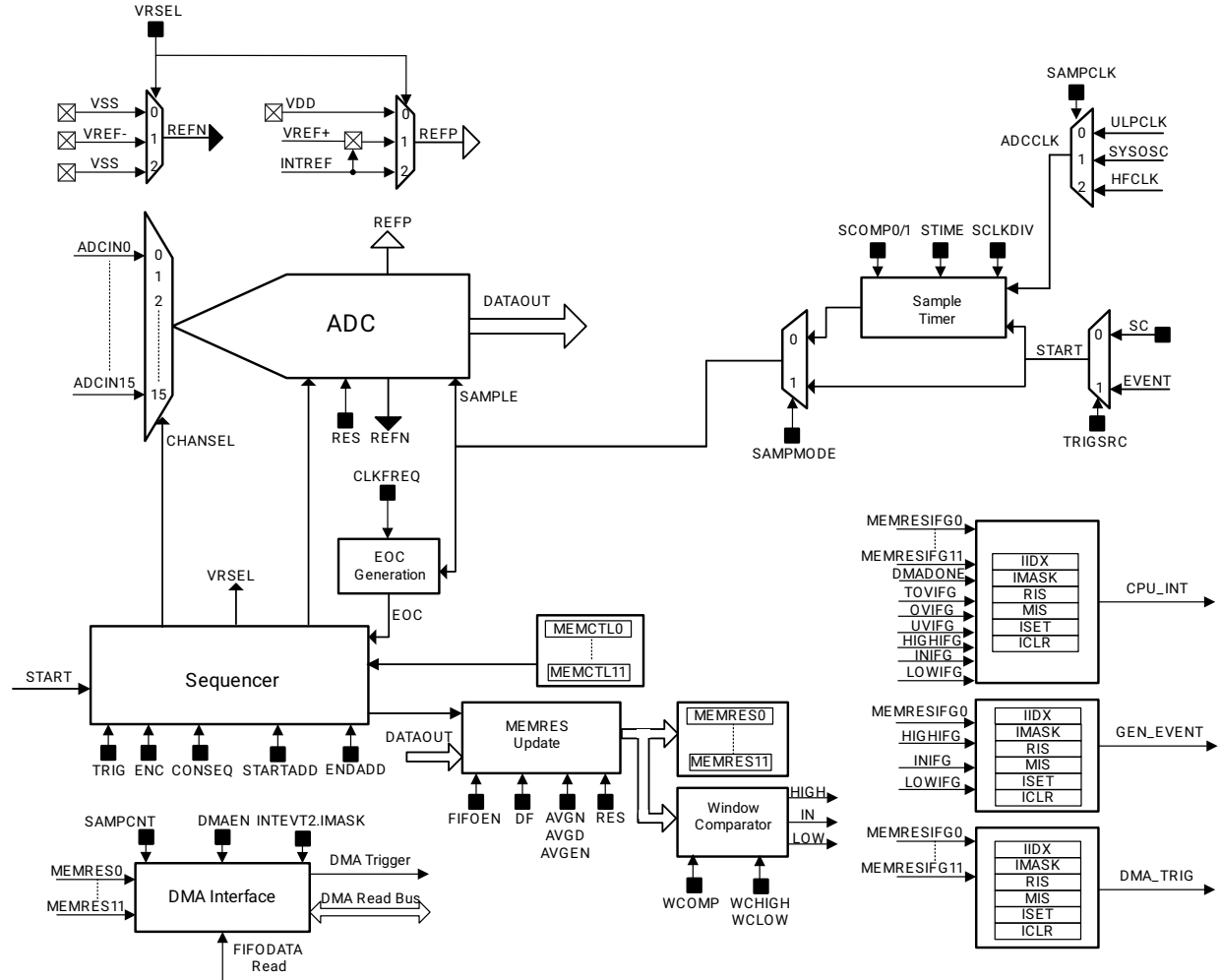


Figure 12-1. ADC Block Diagram

# ADC12

## Reference Voltage Selection

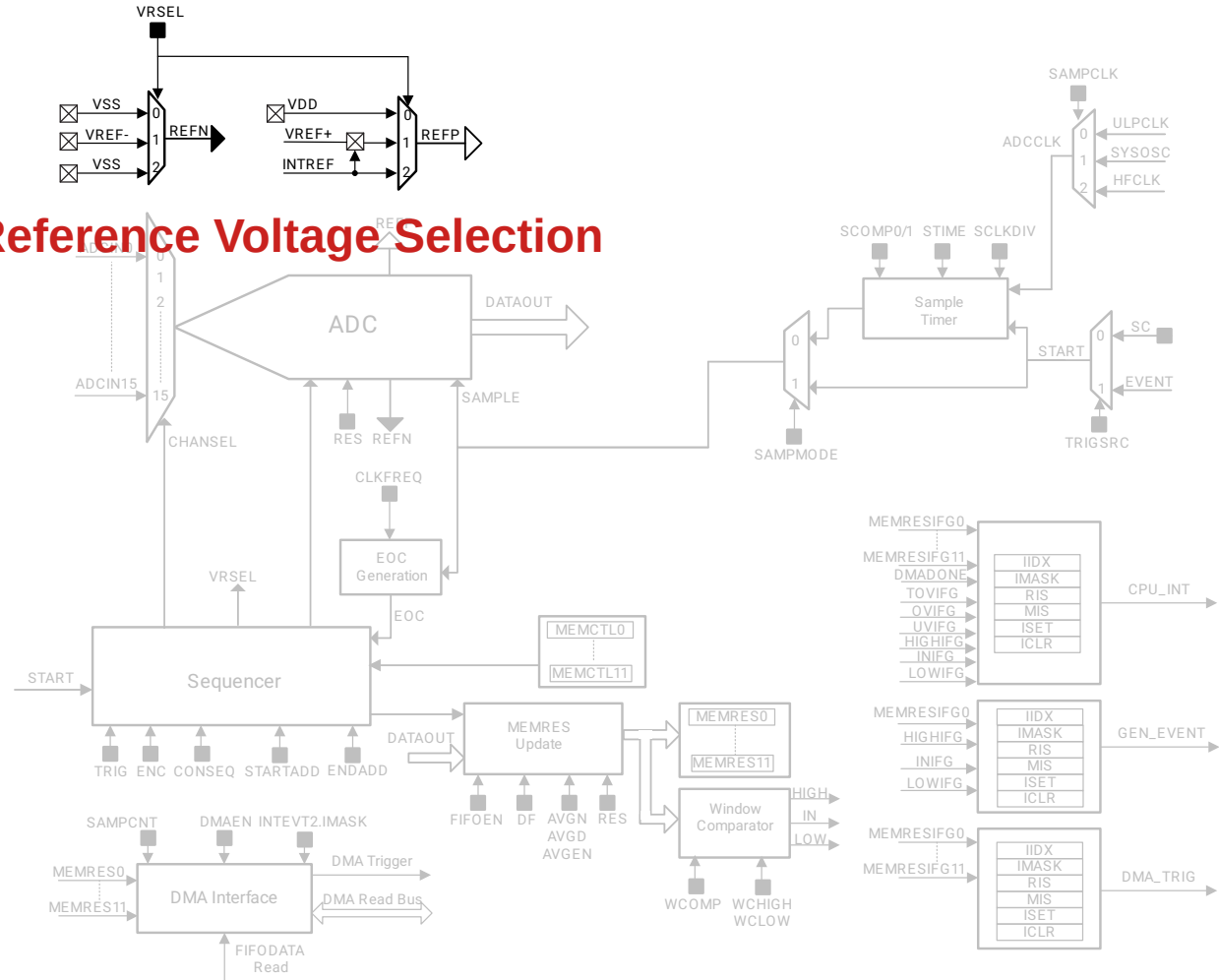


Figure 12-1. ADC Block Diagram

# ADC12

## Channel Selection

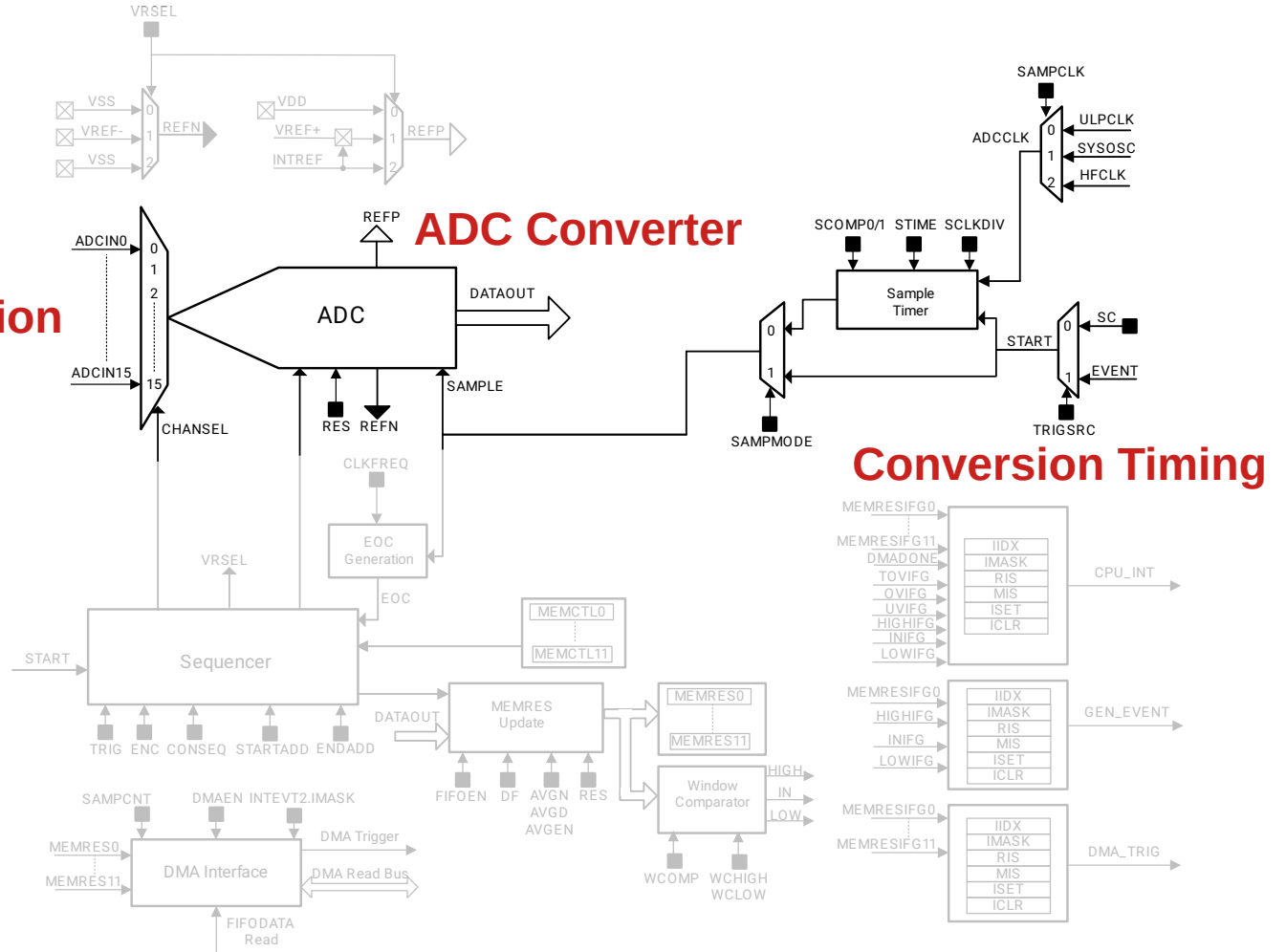


Figure 12-1. ADC Block Diagram

# ADC12

## Conversion Control

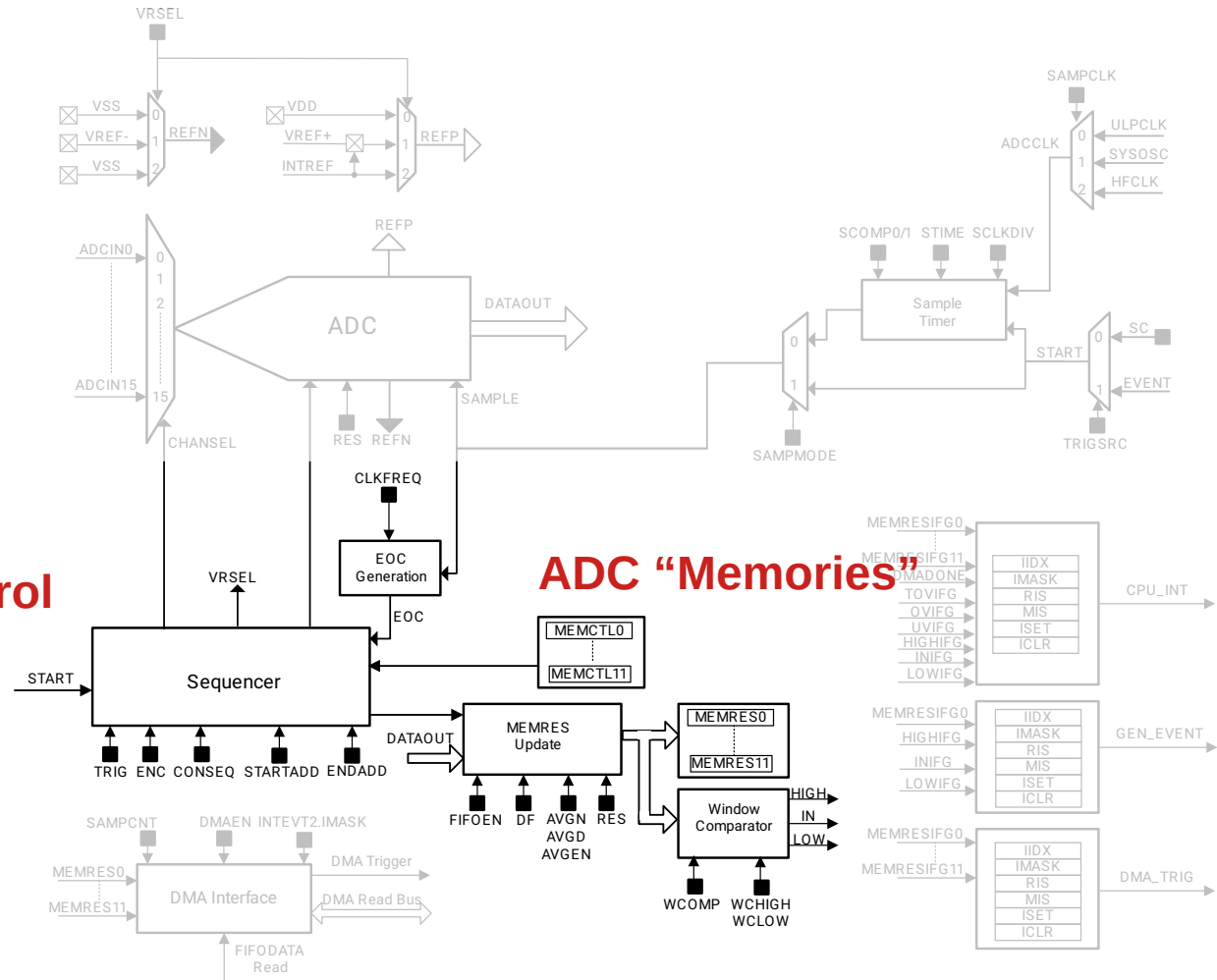


Figure 12-1. ADC Block Diagram

# ADC12

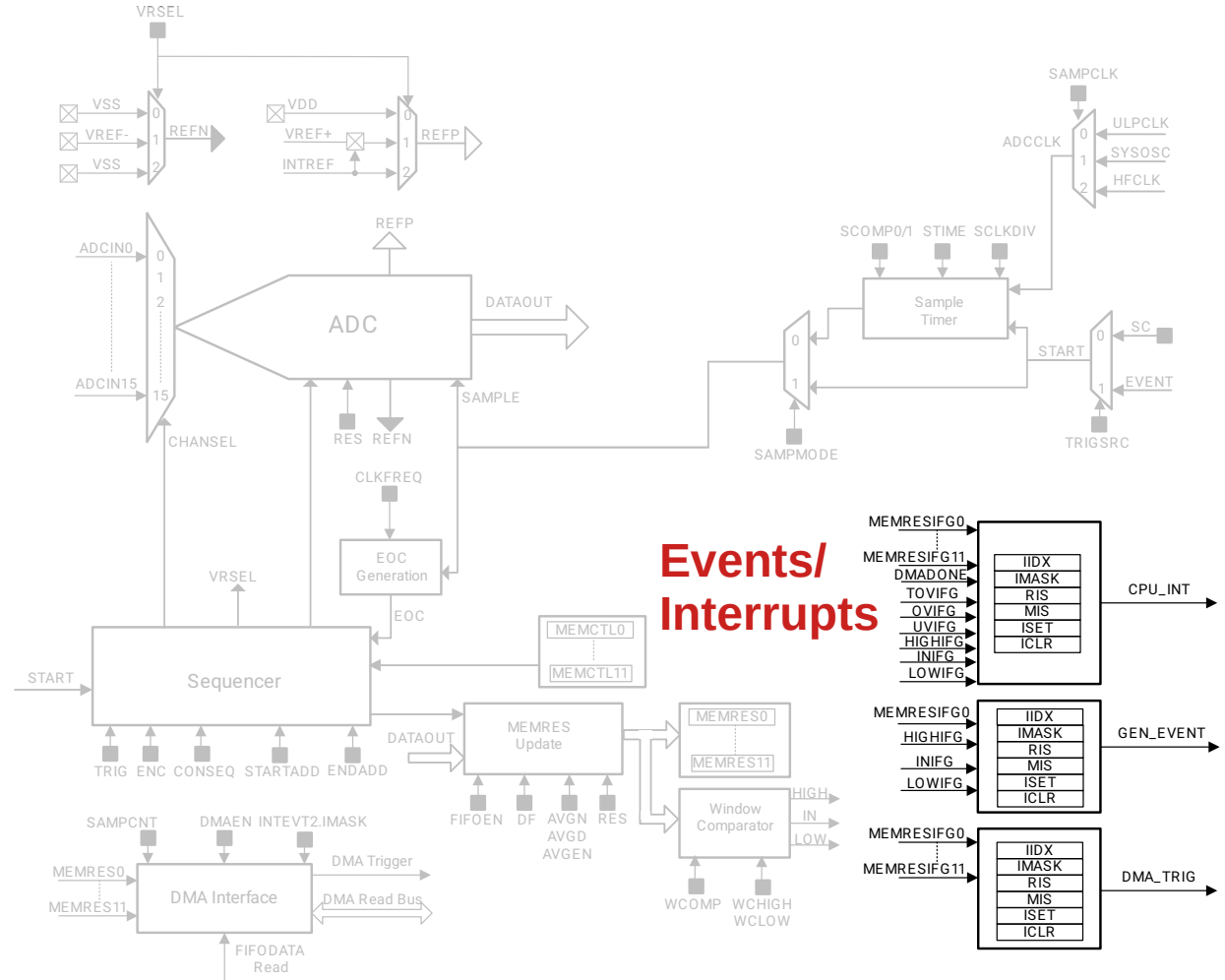
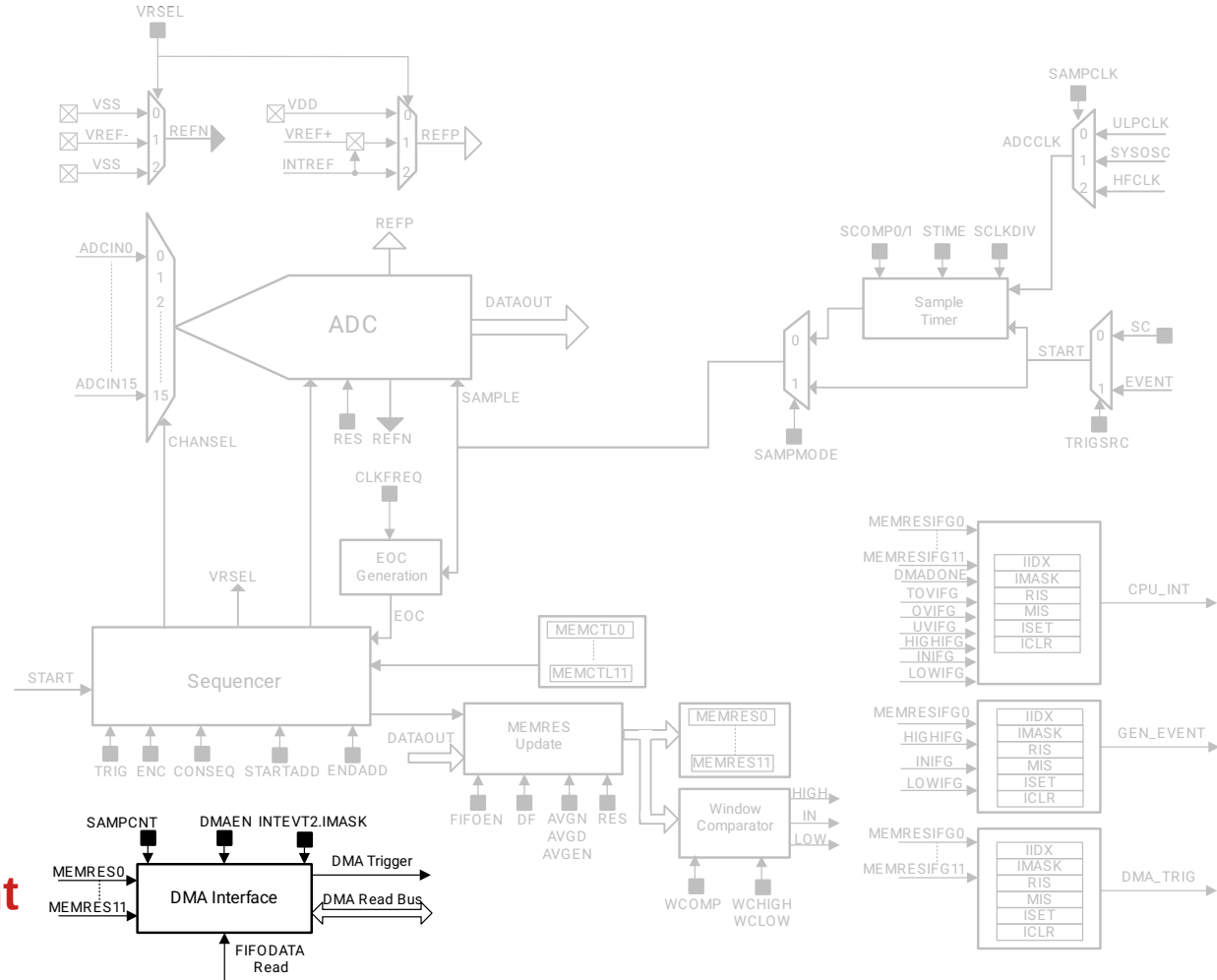


Figure 12-1. ADC Block Diagram

# ADC12



## Hardware Data Management

Figure 12-1. ADC Block Diagram

# ADC12 Configuration

- Conversion timing (ADC Clock)\*
- Resolution (8, 10, 12)
- Triggering modes:
  - Firmware requests single conversions
  - Continuously occurring conversions
  - Event triggered conversions
- Setup of Voltage Reference Value(s)/Source(s)

\* Our EmCon HAL will take care of this; usually has to be configured

# ADC12 Configuration

- Channel Selection:
  - ADC Memories (one per conversion) MEMx
  - ADC Input Channel
  - GPIO Analog Peripheral Function
  - Selection of available VREF for each channel
  - Individual Channel Triggering
  - Sampling Time\*

\* Our EmCon HAL will take care of this; usually has to be configured

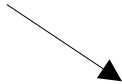
# ADC12: Mapping

- Quantization Minimization is part of ADC12 conversion!
- Conversions always single-ended with  $V_{\text{Ref}-} = 0$

$$N_{\text{ADC}} = 2^{N_{\text{bits}}} \frac{V_{\text{in}+}}{V_{\text{Ref}+}}$$

$$0 \leq V_{\text{in}+} < V_{\text{Ref}+}$$

– Estimated Voltage:


$$\hat{V}_{\text{in}+} = \frac{N_{\text{ADC}}}{2^{N_{\text{bits}}}} V_{\text{Ref}+}$$

# Up Next...

- Lab 3: PWM and Encoders for use on Car
- Quiz 2: March 30<sup>th</sup>:
  - PWM, Encoders.
  - Timer Compare and Capture modes
  - H-bridge use
- Activity 12: ADC Activity (Maybe using DAC as well...)